

**Search Notes**

Application/Control No.

10/702,572

Examiner

Nam V. Nguyen

Applicant(s)/Patent under  
Reexamination

CERN, YEHUDA

Art Unit

2612

**SEARCHED**

Class	Subclass	Date	Examiner
340	310.01	1/28/2008	NN
340	310.05	1/28/2008	NN
340	310.07	1/28/2008	NN
340	506,532	1/28/2008	NN
375	267	1/28/2008	NN
375	295	1/28/2008	NN
375	200	1/28/2008	NN
324	601	1/28/2008	NN
455	63	1/28/2008	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>SAME AS</b>	<b>ABOVE</b>	<b>1/28/2008</b>	<b>NN</b>

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUB; EPO; JPO and Derwent. (updated search)	1/28/2008	NN
Consulted with Benjamin Lee	3/6/2007	NN
Search Term: plcs/plc/plcc; electromagnetic radiation intensity; modem; agc/sensor; frequency band adjust power frequencies	1/28/2008	NN